

Search Notes

Application/Control No.

10/664,779

Examiner

Hoai v. Pham

Applicant(s)/Patent under
Reexamination

CHOI, HYUNG-BOK

Art Unit

2814

SEARCHED

Class	Subclass	Date	Examiner
438	242-244	5/8/2006	HP
438	253-255	5/8/2006	HP
438	387	5/8/2006	HP
438	396-399	5/8/2006	HP
257	303	5/8/2006	HP
257	306	5/8/2006	HP
257	308	5/8/2006	HP
257	311	5/8/2006	HP

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner